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Application/Control No.	Applicant(s)/Patent under Reexamination
10/608,008	LEE ET AL.
Examiner	Art Unit
Dung Nguyen	2871

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Class	Subclass	Date	Examiner	
349	58, 149- 152	4/16/2007	DN	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date ·	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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